1. Scope

Wafer Connector pitch 1.25mm series
This specification covers the Wafer Connector FWF12504/FWF12505 Series

2. Ordering information

Refer to the drawing.

3. Connector dimensions

Refer to the drawing.

4. Material

Housing: PA9T (UL 94V-0) Color: Natural Terminal: Brass

Plating: Tin plated

5. Accommodated P.C.B layout

Refer to the drawing.

6. Rating

Operating voltage(Max.) 125V AC/DC Current rating(Max.) 1.0A AC/DC

Temperature range-operating -40°C -- +85°C(Including terminal temperature rese)

7. Performance

Test item	Requirement	Test Condition					
Electrical Performance							
Contact Resistance	20mΩ Max.	Mate connectors, measure by dry circuit, 20mV MAX., 10mA. Mated Length : 50mm (AWG. #28) (Based upon JIS C5402 5.4)					
Insulation Resistance	100 MΩ Min.	Mate connectors, apply 500V DC between adjacent terminals or ground. (Based upon JIS C5402 5.2/MIL-STD-202 method 302 Cond.B)					
Dielectric Strength No breakdown and flashove		Mate connectors, apply 250V AC for 1 minute between adjacent terminal or ground. (Based upon JIS C5402 5.1/MIL-STD-202 Method 301)					
Contact resistance on crimped portion	20mΩ Max.	Crimp the maximum applicable wire on to the terminal, measure by dry circuit, 20mV MAX., 10mA. Wire Length: 50mm (AWG. #28)					



Test item	Requirement					Test Condition		
Mechanical Performance								
Insertion force and withdrawal force	Refer to paragraph 8					Insertion and withdrawal connectors at the speed rate of 25± 3mm/minute		
Terminal/Housing Retention Force	0.5kgf Min.					Apply axial pull out force at the speed rate of 25±3mm/minute on the terminal assembled In the housing.		
	Wire size #28 #30 #32							
		width		0.9±0.1				
	1	height	0.45~ 0.55	0.40~ 0.50	0.35~ 0.45			
Crimping pull out Force	2	width	0.97			Fix the crimped terminal, apply axial pull out force on the wire at the speed rate of 25±3mm/minute		
Crimping pair out i orce		height	1.35	1.22	1.13	(Based upon JIS C5402 6.8)		
	Crimp strength		1.0kg min.	0.8kg min.	0.5kg min.			
	1. Conductor (mm) 2: Insulation (mm)							
Terminal Insertion Force	0.5kgf Max.					Insert the crimped terminal into the housing at the speed rate of 25±3mm/min.		
Pin Retention Force	0.5kgf Min.					Apply axial push force at the speed rate of 25±3mm/minute on the contact pin assembled in the base wafer.		
	<u> </u>	En	vironn	nental	Perforr	nance and others		
Heat resistance	Appear	rance	No Damage			Mated connector shall be placed in an oven for 96±4 hours at		
	Contact Resistance 40mΩ Max.			Max.		+85±2°C. (Based upon JIS C0021/MIL-STD-202 method 108A Cond.A		
Cold resistance	Appearance No Damage					Mated connector shall be placed in a temperature chamber		
	Contact Resistance 40mΩ Max.			Max.		for 96±4 hours at -40±3°C (Based upon JIS C0020)		
Humidity	Appearance No Damage			mage		Mated connector shall be placed in a humidity shamber as		
	Contac	t Resistance	40mΩ Max.			Mated connector shall be placed in a humidity chamber on the following conditions. Temperature: 60±2°C		
	Dielectric Strength		250V,AC/min			Relative humidity: 90~95% Duration: 96 hours (Based upon JIS C0022/MIL-STD-202 Method 103B Cond.		
	Insulation Resistance 10MΩ Mi			Min.				



Test item	Require	ement	Wafer Connector pitch 1.25mm series Test Condition		
1030 110111	Requirement		l est Condition		
Vibration	Appearance No Damage		Amplitude: 1.52mm P.P		
	Contact Resistance	40mΩ Max.	Sweep time: 10-55-10Hz/minute Duration: 2 hours in each X、Y、Z axlals.		
	Discontinuity 1μ sec Max.		(Based upon MIL-STD-202 method 201A)		
	Appearance	No Damage			
Shock	Contact Resistance 40mΩ Max.		50G, 3 strokes in each X、Y、Z. axlals. (Based upon JIS C0041/MIL-STD-202 method 213B Cond.		
	Discontinuity	1μ sec Max.			
Temperature cycling	Appearance	No Damage	Mated connector shall be set to temperature cycling for 5		
	Contact Resistance 40mΩ Max.		cycles of which 1 cycle consists of: a). +25°C ~ 3minutes b)45°C ~ 30minutes		
	Dielectric Strength	250V,AC/min	c).+25°C ~ 3minutes d).+85°C ~ 30minutes		
	Insulation Resistance 10MΩ Min.		(Based upon JIS C5402 7.2)		
Temperature Rise	30°C Max.		Apply rated current load on mated connector in series- connection. Measure change of temperature on contact using thermocouples for 4 hours. (Based upon UL 1977)		
Repeated Insertion/ withdrawal	Contact Resistance	40mΩ Max.	Mate connector up to 30 cycles repeatedly at a rate of 10 cycles/minute. After which test the contact resistance		
Salt Spray	Appearance No Damage		Mated connector shall be placed in a salt spray chamber on the following conditions. Salt Solution Density: 5±1%		
	Contact Resistance	40mΩ Max.	Temperature : 35±2°C Duration : 24±4 Hours (Based upon JIS C5028/MIL-STD-202 Method 101D Cond.B)		
Solderability	95% of immersed area must show no voids nor pin holes.		Immerse fluxed soldered section of contact pin into a solde bath for 3±0.5sec Temperature: 230±5°C		
Resistance to soldering heat	No Damage in appearance		Mated connector shall be dipped on solder bath for 5±0.5sec Temperature: 260±5°C		



8. Insertion force and withdrawal force

(Unit:kgf)

	In a cuttion (Mass) NA/the dues and (Mic.)							
Circuits	Insertion (Max.)	Withdrawal (Min.)						
	Initial	Initial	10th	30th				
2	2.0	0.28	0.23	0.18				
3	2.5	0.30	0.25	0.20				
4	3.0	0.33	0.28	0.23				
5	3.5	0.38	0.33	0.28				
6	4.0	0.43	0.38	0.33				
7	4.5	0.48	0.43	0.38				
8	5.0	0.53	0.48	0.43				
9	5.5	0.56	0.51	0.46				
10	6.0	0.59	0.54	0.49				
11	6.5	0.62	0.57	0.52				
12	7.0	0.65	0.60	0.55				
13	7.5	0.68	0.63	0.58				
14	8.0	0.71	0.66	0.61				
15	8.5	0.74	0.69	0.64				